Simulation of Track Distortion due to Inhomogeneity of Electric Field in Micromegas modules

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Motivation of the Study

- Developing a better understanding on Distortion
- Understanding the mis-alignment.
- Exploring scope for improvement.

Simulation Tool:

>Garfield Framework

>Field Solver -> neBEM

≻Gas Transport → Magboltz

Primary Ionization → Heed

► Electron Drift → Monte Carlo

The module arrangement



Micromegas modules on the **LPTPC endplate.**

Module size: 17 cm × 22 cm. reference frame is in r-phi system.



Module size: 3.4 cm × 3.4 cm. reference frame is Cartesian.



Drift of electrons (Monte Carlo) at B = 1 T.



Distortion comparison at B = 0 T



Experimental observation (Thesis W. Wang) **Observation from Simulation**





Observation from Simulation

Experimental observation









Due to the curve edge, there exist both Y and X component Of (distorted) electric field.

 $\mathsf{E}_{\mathsf{dist}}$

Non zero E_x gives rise residuals in X at B = 0T.

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System used:

(1) DELL Precision T7500 Work Station/12 cores/ 72 GB RAM.(2)Xeon cluster @ 1.2 GHz/6 cores/ 16 GB RAM.

Thank You

Backup Slides

At the vicinity of the Module edges,

The three components of the Electric Fields are plotted in X, Y and Z

Ez:Ey:Ex

